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Abstract

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Traveling-Wave Photodetectors With High Power–Bandwidth and Gain–Bandwidth Product Performance

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Abstract—Traveling-wave photodetectors (TWPDs) are an attractive way to simultaneously maximize external quantum efficiency, electrical bandwidth, and maximum unsaturated output power. We review recent advances in TWPDs. Record high-peak output voltage together with ultrahigh-speed performance has been observed in low-temperature-grown GaAs (LTG-GaAs)-based metal–semiconductor–metal TWPDs at the wavelengths of 800 and 1300 nm. An approach to simultaneously obtain high bandwidth and high external efficiency is a traveling-wave amplifier-photodetector (TAP detector) that combines gain and absorption in either a sequential or simultaneous traveling-wave structure.

Index Terms—Amplifier, GaAs, high speed, InGaAsP, photodetector, traveling wave.

I. INTRODUCTION

Proposed communication systems at 40 Gb/s, 160 Gb/s, and beyond require photodetectors (PDs) with large bandwidths, high quantum efficiency, and high saturation powers. Unfortunately, conventional surface normal photodetectors are limited to bandwidth efficiency products of typically 30 GHz [1], [2] and saturation powers of typically 10 dBm [2]. Resonant cavities [3] or waveguide photodetectors (WGPD) [1], [2], [4], [5] are needed to achieve higher bandwidth efficiency products. To achieve the highest performance, traveling wave structures are required [6]–[10]. These structures combine controlled impedance lines with long absorption regions to achieve extremely large bandwidth efficiency products and high saturation powers.

Two approaches to increase the responsivity are optical gain, described as follows, and avalanche gain [11]–[19]. Approaches to increase the saturation power are increasing the carrier velocity using a uni-traveling carrier PD (UTC-PD) [2], [20], [21] or reducing the optical modal absorption constants and increasing absorption lengths in traveling-wave photodetector (TWPD), WGPD, or periodic traveling-wave photodetector (P-TWPD) structures [10], [22]–[24]. Recently, several research groups have successfully demonstrated the TWPDs with high speed and high-saturation power performance in the 1.55-μm wavelength regime for the applications of analog or digital fiber communication [25], [26].

In this paper, we review recent work on TWPDs with high gain–bandwidth and high saturation power–bandwidth product performances. By utilizing the short carrier trappiing time of low-temperature-grown GaAs (LTG-GaAs) and the superior microwave guiding structure of metal–semiconductor–metal TWPD (MSM-TWPD) [27], record saturation power–bandwidth product performances of LTG-GaAs-based MSM-TWPD have been demonstrated in short (<800 nm) [28] and long (1300 nm) telecommunication wavelengths regimes [29]. Distinct bandwidth degradation behavior, which can be attributed to hot electron effects of photogenerated carriers [30], [31], have also been observed. By utilizing the good speed and output power performances of MSM-TWPD, we have also demonstrated the novel structure of an LTG-GaAs-based terahertz photonic transmitter [32]. By utilizing the fully distributed microwave guiding property of the MSM-TWPD, short carrier-trapping time of LTG-GaAs, and a membrane antenna structure, high conversion efficiency (1.1×10⁻³) can be achieved at 650-GHz frequency [33].

We have also proposed a novel device, the traveling-wave amplifier photodetector (TAP detector), designed specifically to achieve simultaneously very high gain and ultrafast frequency response, through the distributed combination of optical gain and absorption [34], [35]. This paper describes the theory [35], [36] behind the performance of this device as well as device results in GaAs [37], [38] and InP [38]–[40].
II. MSM TWPDs

A. MSM-TWPD Structure

Traveling-wave detectors are attractive because the intrinsic layer can be thin enough that transit time is not a bandwidth limit, and the capacitance is not a bandwidth limit due to the use of a transmission line. MSM detectors are attractive to achieve lower capacitance per unit length and are easier to achieve a 50-Ω transmission line with velocity-matched property [10], which implies the velocity of optical wave and photogenerated microwave signal are almost the same, as compared to the structure of p-i-n detectors [24]. The cross-sectional scheme of a typical MSM-TWPD is shown in Fig. 1(a). The epitaxial structure consists of a thin LTG-GaAs layer (500 nm) for photoabsorption and two AlGaAs layers for optical waveguiding and optical isolation between the GaAs substrate and the LTG-GaAs active layer. A thin (100 Å) AlAs layer is used to avoid As out-diffusion during annealing. The optical waveguiding in the x-direction is achieved by the etched-mesa ridge structure. Three metal stripes are electrodes to collect the photogenerated carriers in LTG-GaAs layer and support a photoexcited microwave guiding mode. By utilizing the self-aligned process, the gap between ground plane (with width \( w_g \)) and center stripe (with width \( w_c \)) can be shortened to 200–300 nm without E-beam lithography. There are some advantages for the narrow gap width of coplanar waveguide (CPW) line, such as the improvement in internal quantum efficiency of PDs and the reduction in dominant microwave radiation loss in the ultrahigh-frequency regime (several hundreds of gigahertz) [41]. Fig. 1(b) shows the top view of the device. The active region of the photodetector (self-aligned photoabsorption region) is integrated with a CPW line in its output for electrooptical (EO) sampling measurement [42] and dc-biasing purposes.

B. MSM-TWPD Characteristics

The dc I–V and EO sampling measurements described below used mode-locked Ti: sapphire and Cr\(^{3+}\): forsterite lasers as the light sources at short (800 nm) and long (\(~1230 \text{ nm}\)) wavelengths regimes, respectively. The geometry structures of measured MSM-TWPDs at these two wavelengths are the same except that the device absorption lengths for 1230 and 800 nm studies are 70 and 12 \( \mu \text{m} \), respectively, due to different optical modal absorption constants [28], [29]. Under short wavelength excitation, the value of obtained quantum efficiency is about 8.1% under 15-V dc bias voltage. This value is similar to that of the reported quantum efficiency of LTG-GaAs-based p-i-n TWPD [43]. Fig. 2 shows the EO measured impulse response under high dc bias voltage (30 V) and high optical excitation energy (\(~71 \text{ pJ/pulse}\)) at short wavelength regime. Its corresponding frequency response is given in the inset and shows a 190-GHz electrical bandwidth. We calculated the peak output voltage (\( V_p \)) to be about 30 V with \(~500 \text{ mA} \) peak output photocurrent, by utilizing the collected photogenerated charge per pulse (\(~2100 \text{ fC} \)), the area of the measured impulse response, and the characteristic impedance (\(~60 \text{ Ω} \)) of integrated CPW transmission line. The dc bias voltage (also 30 V) thus limited the maximum output peak voltage due to external circuit saturation effects. The peak voltage \( V_p \) (\(~30 \text{ V}\)) and electrical bandwidth (190 GHz) product (5.7 THz-V) is the highest among all the reported ultrahigh-speed PDs, including LTG-GaAs-based p-i-n TWPDs (\(~1400 \text{ fC}, 6 \text{ ps}\)) [44], MBE annealed MSM-TWPD (\(~1600 \text{ fC}, 1.5 \text{ ps}, 220 \text{ GHz}, 4.4 \text{ THz-V}\)) [45], InGaAs-based vertical p-i-n PD (\(~7.2 \text{ ps}, 68 \text{ fC}\)) [46], GaAs-based p-i-n TWPD (\(~5.5 \text{ ps}, 59 \text{ fC}\)) [47], unidirectional carrier PD (UTC-PD, \(~3.1 \text{ ps}, 115 \text{ GHz}, V_p : 1.92 \text{ V}\)) [20], and VMDF
This excellent power–bandwidth product of MSM-TWPD is due to the MSM microwave guiding structure but also due to the short carrier trapping time and the high-voltage capability of LTG-GaAs. However, the short carrier trapping time reduces the quantum efficiency in LTG-GaAs-based PDs. Thus, most of the collected carriers travel through extremely short distances where a stronger electric field exists with less space charge screening effect [2], [49].

It is interesting to consider the application of LTG-GaAs-based PDs in the long wavelength communications regime. This GaAs PD is attractive due to its ultrahigh-speed performance, lower cost, and more mature material growth and processing techniques as compared to InP-based devices. The below band-gap absorption in LTG-GaAs is achieved by utilizing a mid-gap defect state to conduct band transitions. However, the small below-bandgap absorption constant results in low quantum efficiency \((\sim 0.6 \text{ mA/W})\) for traditional vertical-illuminated PD structure [50], [51]. However, an MSM-TWPD structure can have reasonable quantum efficiency by properly increasing the device absorption length. The device responsivity under 15-V dc bias was \(\sim 11 \text{ mA/W}\) and is much higher than the reported value of \((\sim 0.6 \text{ mA/W})\) vertical-illuminated MSM PDs structure [51]. The peak output voltage (or power) and the electrical bandwidth of an ultrahigh-speed photodetector depend on the applied bias voltage and the illuminated optical power. Fig. 3 shows the EO measured impulse response with its corresponding frequency responses shown in the inset under optimum dc bias voltage (10 V) and optical excitation energy \((\sim 28 \text{ pJ/pulse})\) for maximum \(V_p\)-bandwidth product performance at long wavelength regime [29]. The maximum \(V_p\)-bandwidth product of 568 GHz V corresponds to a 160-GHz 3-dB electrical bandwidth and a 3.55-V peak output voltage (with 71-mA peak current and 50-Ω load). Compared with state-of-the-art high-power InP-based UTC-PD [2], [20], our device shows a higher bandwidth and peak-output-voltage product.

As shown in Figs. 2 and 3, although the long wavelength MSM-TWPD has a much longer length, the maximum output \(V_p\) is much lower than the case of short wavelength excitation. To understand the nonlinear behavior of LTG-GaAs-based PD under different wavelength excitations (800 versus 1230 nm), we have also performed EO sampling measurements in these two wavelength regimes with different pumping power [30], [31]. Fig. 4 shows the EO measured impulse current responses under 800 nm [Fig. 4(a)] and 1230 nm [Fig. 4(b)] excitations. A to D traces are results under different illumination intensities. Also shown beside the traces are the corresponding collected carrier densities, which can be obtained by dividing the collected charges by the device absorption volumes. The effective device absorption lengths that we used in volume and density calculations are 24 and 12 μm for 1230- and 800-nm wavelength excitation, respectively. The effective device absorption lengths were obtained by comparing photocurrents from different absorption-length devices. For the case of MSM-TWPD, the measured photocurrent will not increase with the absorption length significantly, when its value is over 12 and 24 μm at the measured two wavelengths. We can thus ensure that most of the photogenerated carriers are concentrated on these lengths (effective absorption volume) instead of real geometric lengths (absorption volume) of devices. In Fig. 4(a), under the condition of shorter absorption length and higher collected carrier density compared to the cases of Fig. 4(b), there is much less broadening in the measured EO traces even with the highest collected carrier density (trace D). However, the traces measured at the 1230-nm wavelength [Fig. 4(b)] show serious broadening with increasing collected carrier densities. The observed nonlinear behavior is opposite the general design concept of high speed/power PDs, which are made to achieve less electrical bandwidth degradation in high output-power regime by reducing the optical modal absorption constant and increasing the device absorption length. Fig. 5(a) and (b) shows the measured impulse full-width at half-maximum (FWHM) under short and long wavelength excitations versus dc bias voltage at different optical illumination powers, respectively [30], [45]. As shown in Fig. 5(a), we can clearly see that in most optical pumping energies, as shown in traces of \(B \sim F\), an optimal bias point, which will increase with the optical excitation energy, for the fastest device response exists. We attributed this nonlinear behavior to the combination of different physical processes including carrier lifetime increasing [52], defect saturation, and space-charge screening effects [44], [45]. In the low optical excitation regime the dominant bandwidth limiting factor is carrier lifetime increasing and the FWHM increases with the bias voltage due to carrier heating and intervalley scattering [30], [31] instead of the reported coulomb-barrier lowering effect [52], because the electric field in the optical guiding mode center of our device is not high enough to induce this effect significantly [28], [30], [31]. When the photexcited carrier density increases, the carrier trapping time will increase significantly because defect saturation reduces the carrier capture probability, and the drift time and significant space-charge field of photogenerated carriers start to affect the speed performance of the device. By increasing the dc bias voltage, we can overcome the space-charge field and improve the speed of the device. However, with further increased bias voltage, the FWHM broadens again due to the
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Fig. 4. Normalized E–O sampling traces of LTG-GaAs-based MSM-TWPDs under (a) 800-nm wavelength and (b) 1230-nm wavelength short pulse excitations under different illumination intensities. DC biases were fixed at 10 and 5 V for (a) and (b), respectively.

Fig. 5. FWHM of the measured impulse responses versus dc bias voltages with different optical excitation energies under (a) 800-nm and (b) 1230-nm wavelengths excitation. Optical pumping energy for each trace is labeled on the figure.

lifetime increasing effect as discussed before. At Fig. 5(a), these optimal bias points for narrowest FWHM shift toward higher voltages for higher optical pumping energies due to that fact that a higher electric field is needed to overcome the carrier-induced space-charge field. As shown in Fig. 5(b), all the traces show a more serious broadening as compared to the traces of Fig. 5(a). The reduction of the FWHM with the increase in dc bias voltage, as shown in Fig. 5(a), does not happen in the case of long wavelength excitation. These measurement results imply that the dominant bandwidth-limiting factor is the lifetime increasing effect under long wavelength excitation. We attributed the distinct nonlinear behaviors to the different photoabsorption mechanisms under the excitations of these two wavelengths. For 1230-nm subband-gap excitation, carriers in the mid-gap states can be excited into the Γ valley with high excess energy (~300 meV), which is close to the offset energy (~310 meV) of the L valley relative to the Γ bottom. These photoexcited electrons will suffer from the intervalley scattering effect (Gunn effect) more easily as compared to the case of short wavelength excitation [30], [31]. This effect should reduce the electron capture rate back to the defect states and cause the broadening of the carrier-lifetime-limited device responses. Based on the above discussion, our observed hot carrier phenomena should also take place in LTG-GaAs-based devices under normal band-to-band excitation with photon energy much larger than the bandgap energy. Serious bandwidth degradation of LTG-GaAs-based photomixers have been observed under ~585-nm wavelength excitation [53].

C. Terahertz Generation

By utilizing the fully distributed microwave guiding property of the MSM-TWPD and a membrane antenna structure, we have also demonstrated a novel terahertz photonic transmitter [32], [33] with high conversion efficiency. Compared with other millimeter- or submillimeter-wave emission techniques such as Gunn diodes [54], p-type Ge-based or quantum cascade terahertz lasers [55], [56], and resonant tunneling diodes [57], photonic transmitters have the advantages of simplicity, compactness, wide tunability, and room temperature operations. To test the performance of our fabricated device, the light source that we used was a mode-locked Ti:sapphire laser with 100-fs optical pulsewidth and 82-MHz repetition rate. By passing the broadband femtosecond optical pulses through etalons, we can increase the repetition rate of the light source to terahertz frequency range and trigger the photonic transmitters by coupling this high-repetition-rate light into the edge-coupled MSM-TWPD [32], [33]. The top view of our device is shown in Fig. 6, which is composed of a MSM-TWPD, a radio frequency (RF) choke filter, and a planar antenna [33]. We adopted a CPW fed slot antenna because it can generate higher power than the spiral antenna in the designed resonant frequency [58] and can be easily integrated with the MSM-TWPD. The RF choke filter, which acts as an inductance [41], avoids the high-frequency ac current (with a resonant frequency of the slot line antenna) leaking into the dc probe pad. We removed the GaAs substrate and mounted the membrane of the fabricated device on a glass substrate, which has a much lower dielectric
constant than GaAs substrates and can thus allow the radiation of terahertz energy into the substrate or free space without using a Si lens [32], [33]. Fig. 7 shows the excitation optical power-dependent terahertz output power under a fixed dc bias voltage (15 V) and operating at the resonant frequency of the antenna [32]. The frequency response of the integrated antenna is shown in the inset, which shows a resonance at the designed frequency (15 V). The frequency response of the integrated antenna shows that the collected terahertz radiation power does not follow a quadric relation with optical excitation power [58]. In addition, the trace of fitted squared input optical power (\(P_{in}^2\)) shows that the collected terahertz radiation power does not follow a quadric relation with optical excitation power [59], especially in the case of high-power illumination. The observed output power saturation behavior can be attributed to the bandwidth degradation effect as discussed in Fig. 5(a). The edge-coupled structure and high conversion efficiency characteristic of our demonstrated devices are suitable for monolithic integration with a mode-locked semiconductor laser with high repetition rate or a two-wavelength continuous-wave diode laser. The integrated device can act as a compact all solid-state and tunable terahertz radiation source.

III. TAP DETECTORS

There are three approaches to making traveling wave amplifier photodetectors. One approach is to sequentially combine absorption and gain regions [Fig. 8(a)]. The segments are designed such that the peak local photocurrents remain below saturation levels. Alternatively, gain and absorption can occur simultaneously as the mode travels down the waveguide. These gain and absorption regions can be arranged laterally [Fig. 8(b)] or vertically [Fig. 8(c)]. We will focus on vertical coupled TAP detectors to avoid the scattering and loss associated with the transitions between sequential TAP regions.

A. Qualitative Performance of TAP Detectors With Vertical Coupling

Fig. 8(d) and (e) shows a top view and cross section of TAP detectors with vertical coupling fabricated in GaAs, respectively. This vertically stacked configuration is an improvement over the originally proposed TAP detectors with lateral coupling [34], [35]. Featuring a quantum well-based amplification region and a bulk detection region, a single-epitaxy structure is grown which allows for the separate optimization of gain and absorption regions. Electrical isolation between these two active regions, which would require processes such as implantation, intermixing, and/or regrowth in a structure presenting gain and absorption regions side by side, is obtained in the vertically stacked configuration through bandgap engineering. In this configuration, a parasitic transistor is formed by the stacking of either p-n-p or n-p-n claddings which allow current injection into the amplification active region and photocurrent extraction from the absorption region. The middle cladding, between both active regions, plays the role of the base in this parasitic transistor, while the lower cladding below the gain active region acts as emitter. Carrier confinement in the gain active region reduces the number of carriers injected into the “base.” A thick middle cladding ensures that a small fraction of those arriving into the absorption diode, result in the inhibition of transistor action. Simultaneous measurement of the background current in the detection diode and the amplified spontaneous emission (ASE) produced in the amplification region, in the absence of an optical input, confirmed that the fraction of background current produced by the action of this parasitic transistor was in fact negligible for good device design [38].

The EO response of TAP detectors is given by the superposition of the photocurrents generated by three types of modes, exhibiting different behaviors. We denote these three types of modes as “detector modes,” “amplifier modes,” and “cladding modes.” Detector modes have a large overlap with the absorption region. They are short lived, propagating over short lengths (\(\sim 10–50 \mu m\)) before being fully absorbed. They are not heavily influenced by the gain in the amplification
Fig. 8. TAP detectors with (a) sequential gain and absorption along the length of the detector, (b) simultaneous lateral gain and absorption, and (c) simultaneous vertical gain and absorption. (d) Top and (e) end view of fabricated vertical coupled GaAs-based TAP detectors.

region, and their response does not significantly depend on the bias current applied between bottom and middle claddings (bias current injected into the gain diode). They are responsible for generating most of the photocurrent detected when the gain diode is left unbiased. Amplifier modes exhibit a large overlap with the gain region and a smaller overlap with the detection region. These modes may actually reach a zero net gain, through the joint action of amplification, absorption, and loss. This “zero modal gain” situation is, in fact, the most interesting operating point for TAP detectors [34]. They are responsible for most of the photocurrent increase as a higher bias current is injected into the gain diode, thus enabling a higher than 100% external quantum efficiency. Cladding modes reside mostly on the bottom cladding, overlapping partially with the gain region, and barely with the absorption region. These modes experience a relatively large net gain when amplifier modes are close to zero modal gain, producing a large increase in the guided optical power, but barely contributing to the total photocurrent detected. In order to fully understand the behavior of TAP detectors, we need to take into account the simultaneous presence of these three types of modes, together with the measurable photocurrent. We define the measurable
photocurrent at a given gain diode bias current as the difference between the total detection diode current measured in the presence and in the absence of an optical input. As the input optical power increases, stimulated recombination depletes the electrical carriers injected into the gain region at a faster rate, resulting in a lower production of spontaneous emission and ASE for the same gain diode bias current. This results in the measurable photocurrent being, in fact, lower than the actual amount of photocurrent produced [38]. This difference between actual and measurable photocurrent increases as the gain diode saturates and is a direct consequence of the impossibility to separate the detection diode current generated by absorption of either optical input signal, spontaneous emission, or ASE.

B. Experimental Results

With this qualitative background, we can explain the experimental results that are observed. Fig. 9(a) shows the index profile and the mode structure of the TAP detector. Fig. 9(b) shows the measurable photocurrent obtained in the first GaAs TAP detectors with vertical coupling [35], as a function of the vertical displacement of the lensed fiber used to couple light into the device. The lowest photocurrent is obtained for the largest vertical displacement, corresponding to the lowest position of the fiber with respect to the device. At this point, most of the power coupled into the device feeds the cladding mode, and only a small fraction of it is transferred into the amplifier mode. As the displacement is reduced, less optical power is coupled into the cladding mode, resulting in lower competition between signal and ASE for the available gain, with an ensuing increase in the measurable photocurrent. The measurable photocurrent finally decreases again as the fiber is moved above the point which produces optimum coupling into the amplifier mode. At this position (vertical displacement of 0–1 μm), an enhanced coupling of the input signal into the detector mode produces a larger photocurrent when the gain diode is left unbiased, but little improvement is obtained by increasing the gain diode bias current, as little power is coupled into the amplifier mode.

To eliminate the cladding mode, the index of refraction of the bottom cladding was reduced, by increasing its aluminum fractional content from 15%–20% to 25%, and the external quantum efficiency improved to over 200%. The reduction in the device efficiency through competition between ASE and optical signal for the available gain is still clearly shown in Fig. 10, as the measurable efficiency decreases with increasing input optical power. From Figs. 9 and 10, we may therefore conclude that inhibition of parasitic modes that do not overlap with the absorption region does indeed improve TAP detector performance and that further improvements are possible as long as the effect of the competition between ASE and signal is reduced.

C. Advantages of TAP Detectors With Alternating Gain and Absorption

TAP detectors featuring alternating gain and absorption, shown in Fig. 8(a), present a priori several advantages over a vertically stacked configuration. The main ones are superior microwave propagation characteristics [34], [35], the possibility to introduce integrated ASE filtering, and the elimination of most of the contribution to the background current from absorption of nonamplified spontaneous emission. The price for these advantages is higher device fabrication complexity. Once the concept of distributed combination of gain and absorption has been demonstrated using the easier-to-fabricate vertically stacked configuration, TAP detectors with alternating gain and absorption are ideal candidates for future performance improvements. Before describing in detail the advantages of one configuration over the other, it is noteworthy to mention that other performance parameters not compared in this paper, such as the external quantum efficiency or generation of background current due to absorption of ASE, are virtually identical in both configurations. This is due to the fact that, conceptually, a stacked configuration is nothing more than a “continuous” version of a TAP detector with alternating gain and absorption, where each differential element of length may be subdivided in
two smaller elements, one providing gain and one absorption. In other words, a TAP detector with vertical coupling may be treated as a TAP detector with alternating gain and absorption featuring an arbitrarily large number of periods of very short length each.

Although the contribution to the total background current from absorption of spontaneous emission may be much smaller than the contribution from absorption of ASE in TAP detectors with vertical coupling [38], we believe this to happen only when amplifier modes experience relatively large net gain. In fact, we believe that it is the competition between ASE and spontaneous emission for the electron–hole pairs available for recombination that makes this happen. In other words, in the most interesting operating point where the net modal gain approaches zero for amplifier modes, the contribution from spontaneous emission to the background current in TAP detectors with vertical coupling is far from negligible. A configuration featuring alternating gain and absorption significantly reduces this contribution to the background current. This reduction stems from the much smaller solid angle of absorption region subtended from any point in the amplification region, device length being in the order of a few hundreds of microns, while the width and thickness of the active regions are on the order of a few microns and a few hundreds of nanometers, respectively.

The superior microwave propagation performance is a direct consequence of the signal-carrying electrode being deposited mostly over the insulator as shown in Fig. 8(a). This electrode has a relatively small periodic interaction with doped semiconductor layers, typically for about 10% of its total length. Distributed photocurrent simulations have shown this interaction to produce characteristic impedance close to 50 Ω, small velocity mismatch between electrical and optical velocities, and small microwave propagation loss [34], not too differently from the case of velocity-matched photodetectors (VMPDs) [10]. Fig. 11 shows the simulated high-speed performances of both configurations, clearly proving this advantage. The frequency response is plotted for different values of the net modal gain per unit length Δg and for different device lengths L in the case of TAP detectors with vertical coupling in Fig. 11(a) as well as different values of the net gain per period ΔG and different numbers of periods N in the case of TAP detectors with alternating gain and absorption in Fig. 11(b). Δg is defined as the net rate of change in the optical power per unit length, while ΔG is the ratio between the optical powers arriving at the beginning of two consecutive device periods. Both parameters are assumed to be constant throughout the entire device. All periods in the TAP detector with alternating gain and absorption are assumed to be identical, and their length is set at 50 μm. Details of the simulated structures are contained in [60]. Fig. 12 plots the simulated response of TAP detectors with alternating gain and absorption presenting a 50-Ω terminated input where photocurrent contributions collected at both the input and output are added. This comparison allows us to determine the bandwidth-limiting

![Fig. 10. Measured external quantum efficiency in vertically coupled GaAs-based TAP detectors from an optimized epitaxial structure designed to remove cladding modes, as a function of the amplifier bias current, and for different values of the input optical power. Device length is 200 μm, and its front facet was antireflective coated.](image1)

![Fig. 11. (a) Simulated frequency response for TAP detectors with vertical coupling for different values of the net gain per unit length Δg and different device lengths L. Δg is 0 (full lines) –20 cm⁻¹ (dashed lines), and 20 cm⁻¹ (dotted lines). (b) Simulated frequency response for TAP detectors with alternating gain and absorption for different values of the net gain per period ΔG and different number of periods N. ΔG is 1 (full lines), 0.5 (dashed lines), and 2 (dotted lines).](image2)
facilitate the discussion, the input signal wavelength will be chosen such that it lies outside the emission spectrum of the gain medium. Since the ASE generated in each gain section accumulates and gets amplified throughout the device, this scheme may produce a very significant reduction in the total ASE generated. This result not only in a lower background current generated in each absorption section from ASE produced in the immediately neighboring gain sections, but also in a much slower overall ASE buildup along the device. The input signal, being of a wavelength intermediate between the band edges of absorption and filtering active regions, would suffer a very small attenuation in each filtering section, resulting in a slightly reduced actual efficiency. However, the significantly lower background current due to ASE absorption more than compensates for this small reduction, for different reasons. First, the signal to background ratio severely increases. Next, the effect of competition between signal and ASE is largely reduced, not only because a much smaller fraction of that ASE is now absorbed, resulting in a much less important decrease of the background current for the same ASE power reduction, but also because the much slower ASE buildup delays saturation of the amplification region to much higher values of the net gain per period, the effect being dramatically reduced in operating points close to cancellation between gain, absorption, and loss for the input signal wavelength in each period. Thus, the measurable photocurrent approaches the value of the photocurrent actually generated by the distributed amplification and absorption of the input signal, and this is true for a much larger range of input optical powers, resulting in a larger measurable efficiency, constant over a wider range of the input optical power. Finally, noise generation decreases, due to a dramatic reduction in the classically denoted spontaneous–spontaneous beat noise term, generated by the absorption of ASE subject to random amplification. The combination of these factors may result in a dramatic improvement in the spurious-free dynamic range (SFDR) of TAP detectors through the introduction of integrated optical filtering, which is possible using state-of-the-art intermixing techniques.
D. Noise in TAP Detectors With Alternating Gain and Absorption

Before establishing the concluding remarks, it is necessary to provide at least a brief description of noise properties of TAP detectors. Using a new particle-like noise model that we have developed for devices featuring a distributed combination of optical amplification and photodetection [60], [61], the noise figure of TAP detectors and the main factors influencing it may be calculated. The new noise model is based on calculating the evolution of the moments of the photon and electron number probability distributions, similarly as the photon statistics master equation [62] calculates the evolution of the photon number probability distribution itself. Both models produce thus equivalent descriptions of the optical noise generated through the amplification process. The photocurrent noise may be described through the electron number variance, which may, in turn, be calculated from the correlation between electron and photon numbers. The new model describes also the evolution of these two quantities, allowing us to calculate the signal-to-noise ratio (SNR) for the output photocurrent as the ratio between the square of the average electron number and the electron number variance. Evaluating in a similar way the input optical SNR, the noise figure for the device may be calculated as a function of the device operating point and of the input optical power.

Using the new noise model, we found an interesting tradeoff: when the net gain per period is close to 1, the noise figure is roughly equal to \(2/3\) of the external quantum efficiency. This is only true when the input coupling efficiency is close to 100\% (no additional partition noise is introduced at the device input), and the spontaneous–spontaneous beat noise term may be neglected in front of the signal–spontaneous beat noise term, i.e., when the photocurrent is much larger than the background current. Deviating from this situation results in a larger noise figure than the minimum value expressed through this proportionality relation.

Figs. 14 and 15 show the noise figure of TAP detectors calculated using the new noise model and assuming full inversion in the gain medium. It is very important to realize the effect of the efficiency of each individual detection section \(\eta^{(1)}\) in the overall noise figure. This efficiency is defined as the photocurrent generated in each absorption section, expressed in electrons per unit time, divided by the optical signal power that arrives to it, expressed in photons per unit time. Fig. 14 shows the noise figure in TAP detectors with alternating gain and absorption as a function of the efficiency of each detection section and for different input optical powers, assuming that the device response is linear, i.e., neglecting saturation and competition between signal and ASE, and assuming that actual and measurable efficiencies are equal. More exactly, it shows the noise figure in the particular case where gain, absorption, and loss exactly cancel out in each period, resulting in the same optical power arriving to each detection section. The gain of each amplification section is assumed to be modified by changing bias current into the gain diode in order to achieve this operating condition for the different values of the efficiency of each section. Note that there is a minimum in the noise figure for a value efficiency of each detection section that depends on the input optical power. When the efficiency of each absorption region is close to one, the amount of optical power surviving each detection region is very small, resulting in a large amount of partition noise. When the efficiency of each detection section is close to zero, the gain section needs to be biased just above transparency to achieve net gain per period equal to one (constant optical power arriving to each absorption section). A very small amount of photocurrent is generated, while spontaneous emission is produced and absorbed, resulting in a large amount of spontaneous–spontaneous beat noise relative to the photocurrent. For intermediate values of the efficiency of each detection section, the signal–spontaneous beat noise term dominates. The relative magnitude of this latter term with respect to the spontaneous–spontaneous beat noise contribution depends on the input optical power. Since the spontaneous–spontaneous
and signal-spontaneous noise terms depend differently on the efficiency of each absorption section, different input optical powers correspond to different values of this efficiency for which the minimum noise figure is obtained. It also becomes apparent that integrated optical filtering (not considered in the simulation results shown in Figs. 14 and 15) is necessary to allow for the device noise figure to approach its optimum value. This optimization would be a result of the reduction of the spontaneous—spontaneous beat noise term.

Fig. 15 shows the noise figure as a function of the net gain per period, for an efficiency of each absorption section featuring a realistic value of 50%. The value of the net gain per period for which the noise figure drops to zero corresponds to a zero bias current injected in the amplifier, hence no spontaneous emission or ASE is produced. It is noteworthy that when the bias current injected into the gain diode reaches realistic values, the noise figure is a relatively flat function of the net gain per period. In other words, as the net gain per period raises above one, the performance of TAP detectors becomes similar to that of a semiconductor optical amplifier (SOA) followed by a traditional photodiode, since an increasingly larger fraction of the total photocurrent is produced in the last absorption section, where the arriving optical power is maximum. Therefore, biasing the amplification regions such that the net gain per period is just above one, we may obtain a large external quantum efficiency (in the order of 100%), a large bandwidth (in the order of 100 GHz) while maintaining a noise figure similar to that of traditional SOAs. Note that in Figs. 14 and 15 the effect of the input coupling loss (assumed to be 50%) in the total noise figure is already taken into account and that the first active section in the device is an absorption section (the first gain section shown in Figs. 8(a) and 13 is assumed not to exist in this case). The noise figure of TAP detectors may be decreased by introducing a longer independently biased first gain section before the first absorption section. This approach also contributes to enhance the external quantum efficiency, allowing for multiterahertz bandwidth-efficiency products with 6–8-dB noise figures, while the optical power inside the device never grows beyond ten times the input optical power.

IV. CONCLUSION

In summary, we have reviewed our recent work on TWPD with ultrahigh power—bandwidth and gain—bandwidth products performance. By utilizing the superior microwave guiding structure of MSM-TWPD and the short carrier-trapping time of LTG-GaAs-based photoabsorption layer, record high power—bandwidth product performances have been demonstrated under short and long wavelength excitation. Different nonlinear behaviors in these two wavelength regimes have been observed under high-power illuminations. Compared with the bandwidth degradation behavior of short excitation wavelengths (≈800 nm), the saturation behaviors under long wavelength excitation are more serious and can be attributed to more serious hot electron and intervalley scattering effect of photogenerated carriers with high excess energy (≈300 meV). By using the edge-coupled MSM-TWPD with its superior microwave guiding properties, we have also demonstrated a novel membrane terahertz photonic transmitter without the integration with Si lenses and attained record high optical-to-terahertz power conversion efficiency (≈1.1×10^−3) at 650 GHz under pulse mode operation condition.

We have also shown experimental results on a novel device, the traveling-wave amplifier photodetector, presenting external quantum efficiency in excess of 200% at short wavelength (850 nm) and in excess of 100% at long wavelength (1.55 μm). We have also proposed the fabrication of these devices in a configuration presenting alternating optical gain and absorption, which could improve their efficiency and linearity, through the introduction of integrated optical filtering, while at the same time allowing for higher frequency response (bandwidth in the order of 100 GHz). An optimized configuration would furthermore feature an initial amplification section with a double purpose, i.e., further enhancement of the external efficiency and reduction of the noise figure.

REFERENCES


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